Valley Splitting in strained Si quantum dots

Objective:

• Obtain energy levels and valleysplitting trends of strained Si quantum dots embedded in Si_{0.75}Ge_{0.25} for dimensions relevant to qubit implementation.

Approach:

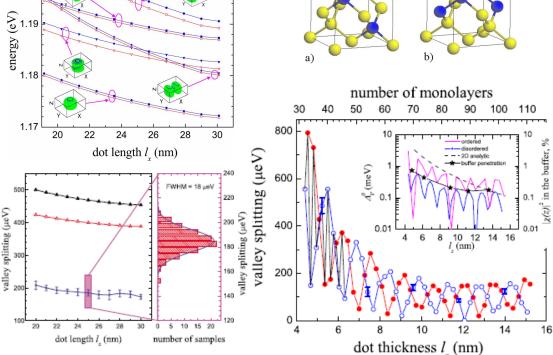
•Use NEMO 3-D

- Strain Relaxation: VFF Keating.
- Incorporated different levels/ orientations of buffer disorder.
- Typical dimensions: Lx=25nm, Ly=20 nm, Lz ~10nm. 80nm³ buffer.

Impact:

- Atomistic approach is essential
- Comprehensive study of Si-QDs that provides a reliable

benchmark for experimentalists.



Result:

- Valley splitting depends on the wavefunction fraction penetrating into the buffer.
- Valley splitting is suppressed as buffer disorder increases.
- Valley splitting is unaffected by strain.



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